

**Search Notes**

Application/Control No.

10/665,566

Examiner

Sunray Chang

Applicant(s)/Patent under  
Reexamination

TAJIIKA, YOSUKE

Art Unit

2121

**SEARCHED**

Class	Subclass	Date	Examiner
700	12,65,66	5/11/2007	SC
709	217-220	5/11/2007	SC
711	100-113	5/11/2007	SC
711	162-165	5/11/2007	SC
704	251 270	5/11/2007	SC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	5/11/2007	SC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
700	66	5/11/2007	SC
700	12 19	5/11/2007	SC

*PGPUB searched*

700	5/14/07 5/14/2007	SC SC
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